
STM32WB Series BLE interoperability report

Introduction

This document describes tests and results of interoperability of STM32WB55 devices with leading Android™ and iOS™ smartphones.

The testing is performed through two different sessions:

- Basic functional tests such as discovery, connection, GATT procedure
- Application scenarios such as pairing, data transfer measurement (uplink and downlink)

1 Test setup

Table 1. Test setup

Setup Parameter	Description
Mobile phones	Refer to test results
ST device under test	STM32WB55
STM32CubeWB	V1.10.0

Debug traces are enabled in the device under test, and are displayed on a serial console.

Sniffer is launched, air traces are captured and used to measure timings during the different phases (connection, GATT discovery, notification, indication).

Figure 1. Setup overview

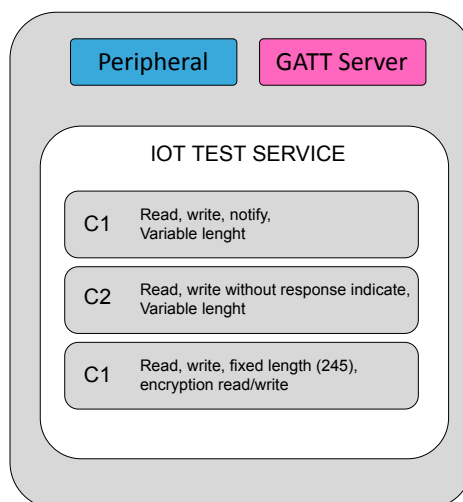


2 Basic functional test cases

2.1 Application of STM32WB Series basic functional test

The test application consists in one service and three characteristics.

Figure 2. BLE IOT test application



2.2 Summary of basic functional tests

Table 2. List of basic functional tests

Test set	Test case	Type
1	1	BLE scanning, discovery
2	1	BLE connection
	2	GATT (service, characteristic discovery)
3	1	GATT notification <ul style="list-style-type: none"> Variable length data C1
4	1	GATT write/read <ul style="list-style-type: none"> Variable length data C1: write 1 byte 0xAA, read 0xAA
	2	GATT write/read <ul style="list-style-type: none"> Variable length data C1: write 4 bytes 0x55443322, read 0x55443322
5	1	GATT indication <ul style="list-style-type: none"> Variable length data C2
6	1	GATT read/write without response <ul style="list-style-type: none"> C2: write 1 byte 0xAA, read 0xAA

Test set	Test case	Type
6	2	GATT read/write without response <ul style="list-style-type: none"> C2: write 4 bytes 0x55443322, read 0x55443322
7	1	GATT read/write with response <ul style="list-style-type: none"> C3
8	1	GAP connection interval change requested by the peripheral <ul style="list-style-type: none"> Connection interval request: 7.5 ms
	2	GAP connection interval change requested by the peripheral <ul style="list-style-type: none"> Connection interval request: 20 ms
	3	GAP connection interval change requested by the peripheral <ul style="list-style-type: none"> Connection interval request: 45 ms
	4	GAP connection interval change requested by the peripheral <ul style="list-style-type: none"> Connection interval request: 200 ms
	5	GAP connection interval change requested by the peripheral <ul style="list-style-type: none"> Connection interval request: 400 ms
	6	GAP connection interval change requested by the peripheral <ul style="list-style-type: none"> Connection interval request: 600 ms
	7	GAP connection interval change requested by the peripheral <ul style="list-style-type: none"> Connection interval request: 1000 ms
	8	GAP connection interval change requested by the peripheral <ul style="list-style-type: none"> Connection interval request: 2000 ms
	9	GAP connection interval change requested by the peripheral <ul style="list-style-type: none"> Connection interval request: 4000 ms
9	1	GAP latency change requested by the peripheral <ul style="list-style-type: none"> Connection interval request: 48.75 ms, connection latency = 2
	2	GAP latency change requested by the peripheral <ul style="list-style-type: none"> Connection interval request: 48.75 ms, connection latency = 4
	3	GAP latency change requested by the peripheral <ul style="list-style-type: none"> Connection interval request: 200 ms, connection latency = 2
	4	GAP latency change requested by the peripheral <ul style="list-style-type: none"> Connection interval request: 200 ms, connection latency = 4
	5	GAP latency change requested by the peripheral <ul style="list-style-type: none"> Connection interval request: 1000 ms, connection latency = 1

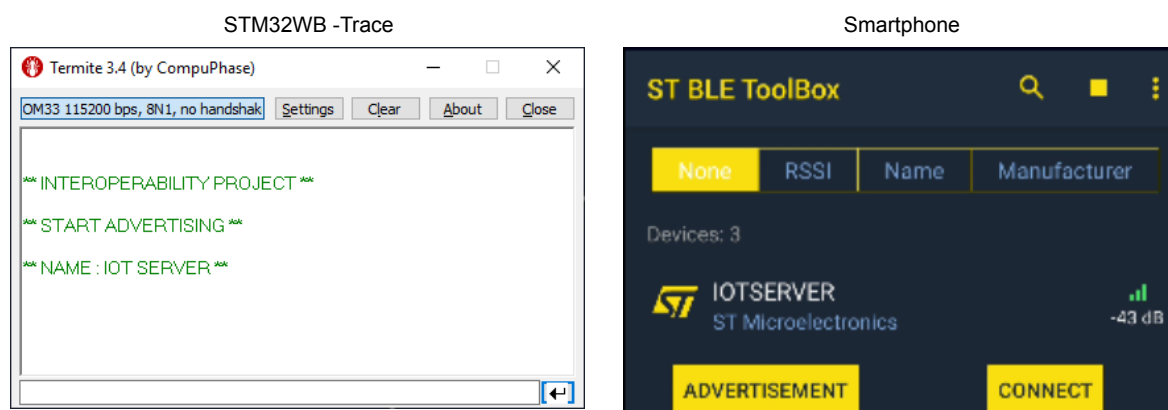
2.3 Description of basic functional tests

2.3.1 Test 1 – BLE scanning, discovery

STM32WB55 device is the peripheral.

- Phone scans and finds the device
- Pass if device is found by the phone

Figure 3. Phone scans and finds the device

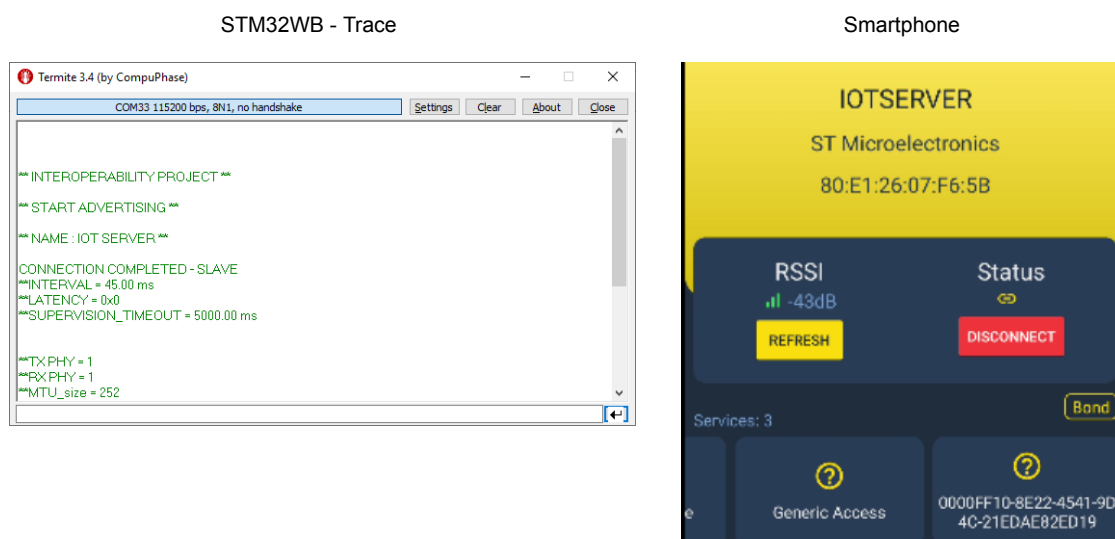


2.3.2 Test 2-1 – BLE connection

STM32WB55 device is the peripheral.

- Phone scans, connects
- Pass if phone connects to the device

Figure 4. Phone connects

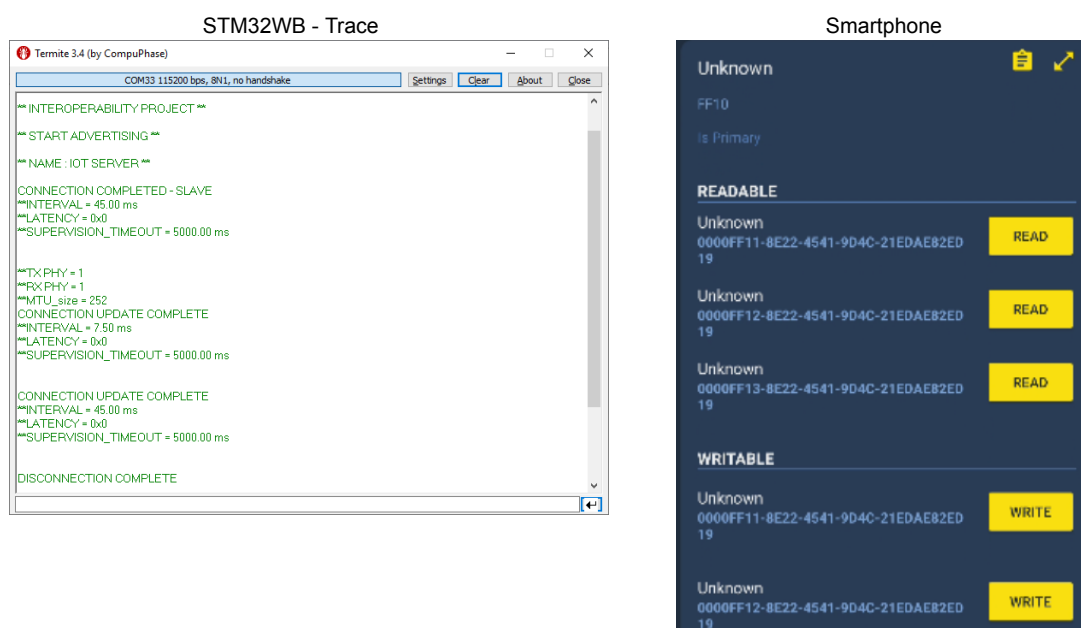


2.3.3 Test 2-2 – GATT, service/characteristics discovery

STM32WB55 device is the peripheral.

- Phone scans, connects, discovers service/characteristic, disconnects
- Pass if no connection issue and all service/characteristics are discovered by the phone

Figure 5. Phone discovers service, characteristics



2.3.4 Test 3 – GATT notification

Phone enables the notification on the characteristic which triggers a timer, at timer expiration (1 s) the notification is sent with expected value.

- Length = 1, data=0x55
- Length = 249 (ATT_MTU-3)

Data: Byte0 = Packet sequence number, byte1 = 1,..., byteN = N

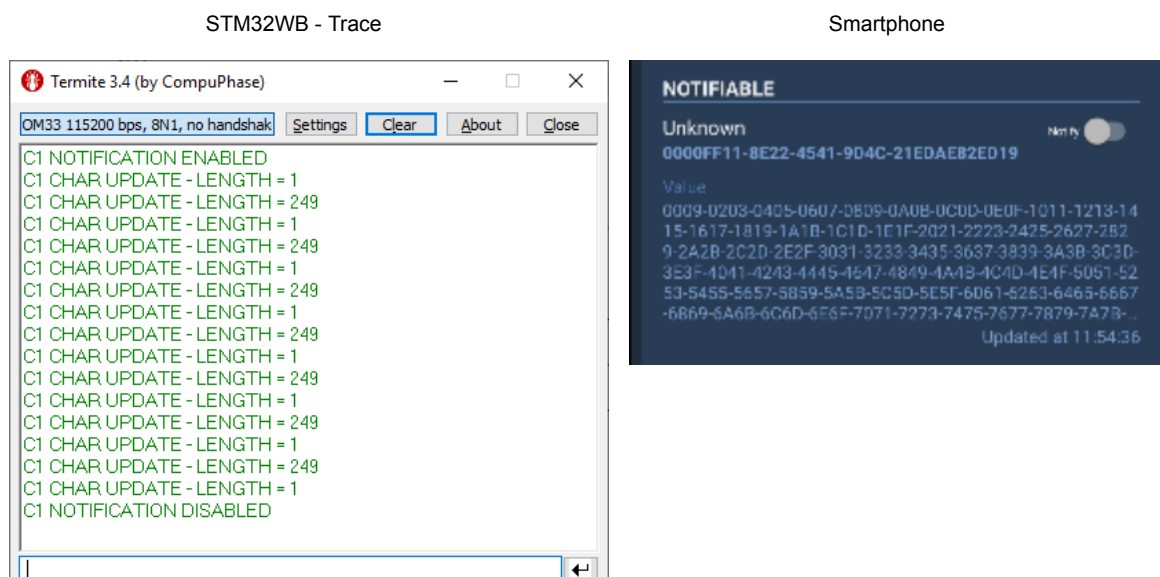
Pass if the notification is received with the corresponding length and value.

- Length = 1, data=0x55
- Length = ATT_MTU-3

Data: Byte0 = Packet sequence number, byte1 = 1,..., byteN = N

Check no errors on phone, check the air trace and debug trace on device application.

Figure 6. Phone enables the notification



2.3.5 Test 4-1 – GATT, write/read characteristic (1 byte)

Phone writes a variable length data, reads the written data.

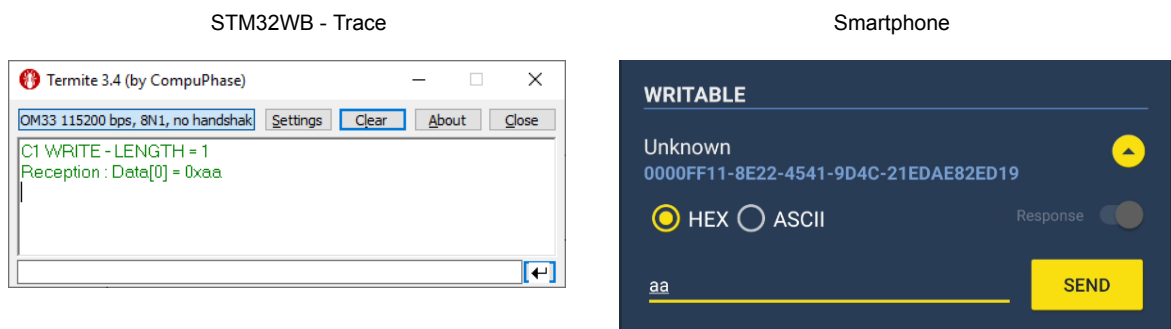
- Length = 1, data = 0xAA

Pass if the read back value equals the written value and if the phone gets:

- 1 byte read back data 0xAA

Check no errors on phone, check the air trace and debug trace on device application.

Figure 7. Phone writes 1 byte (test 4-1)



2.3.6 Test 4-2 – GATT, write/read characteristic (4 bytes)

Phone writes a variable length data, reads the written data.

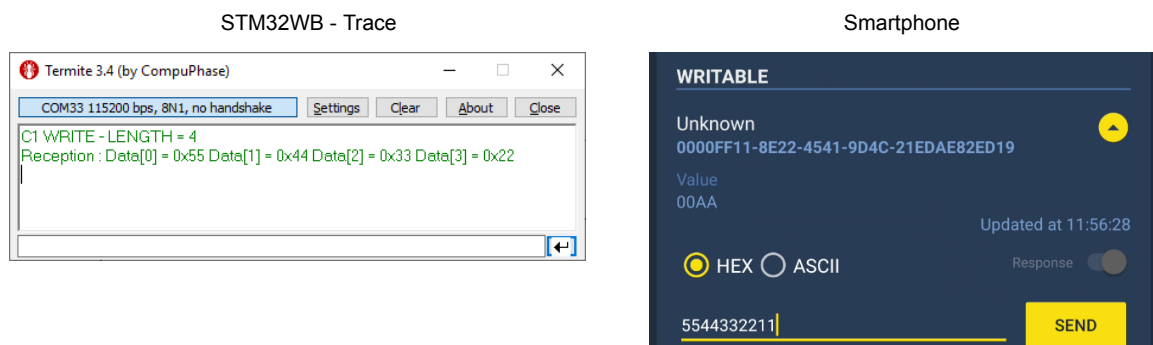
- Length = 4, data = 0x55443322

Pass if the read back value equals the written value and if the phone gets:

- 4 bytes read back data 0x55443322

Check no errors on phone, check the air trace and debug trace on device application.

Figure 8. Phone writes 4 bytes (test 4-2)



2.3.7 Test 5 – GATT indication

Phone enables the indication on the characteristic which triggers a timer, at timer expiration the indication is sent with expected value.

- Length = 1
- data = 0x55
- Length = 249 (ATT_MTU-3)

Data: Byte0 = Packet sequence number, byte1 = 1,..., byteN = N

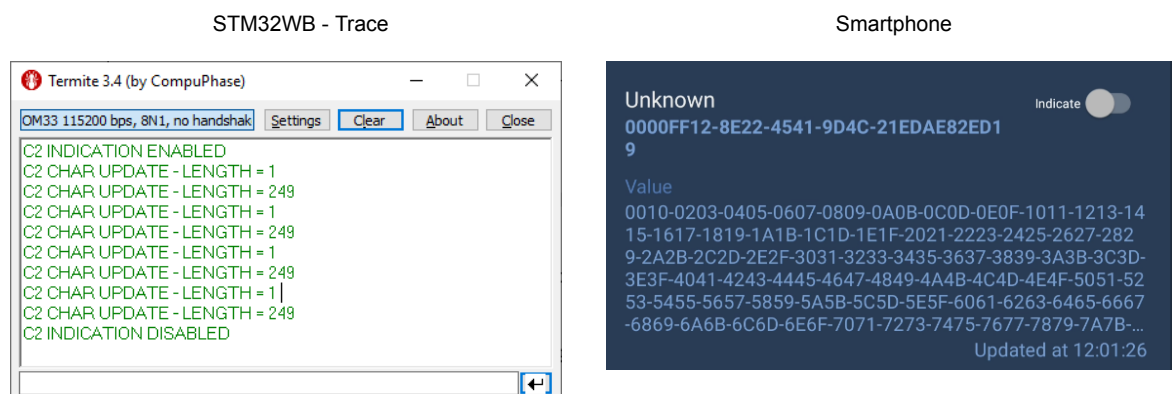
Pass if the indication is received with the corresponding length and value.

- Length = 1, data = 0x55
- length = ATT_MTU-3

data: Byte0 = Packet sequence number, byte1=1,..., byteN = N

Check no errors on phone, check the air trace and debug trace on device application.

Figure 9. Phone enables the indication



2.3.8 Test 6-1 – GATT, write without response/read characteristic (1 byte)

Phone writes a variable length data, reads the written data

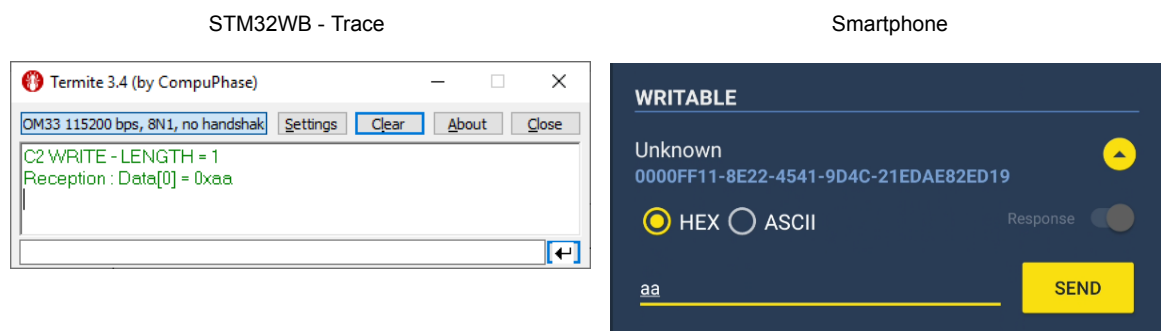
- Length = 1, data=0xAA

Pass if the read back value equals the written value and if the phone gets:

- 1 byte read back data 0xAA

Check no error on phone, check the air trace and debug trace on device application.

Figure 10. Phone writes 1 byte (test 6-1)



2.3.9 Test 6-2 – GATT, write without response/read characteristic (4 byte)

Phone writes a variable length data, reads the written data:

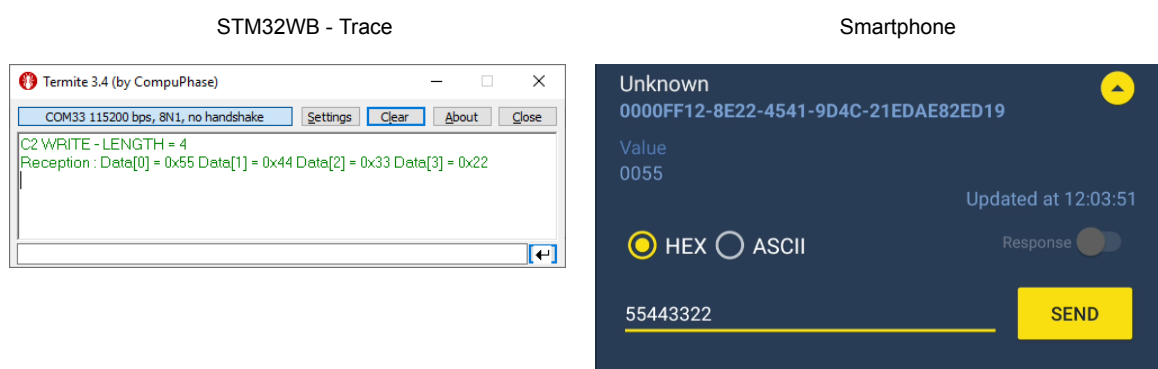
- Length = 4, data = 0x55443322

Pass if the read back value equals the written value and if the phone gets:

- 4 bytes read back data 0x55443322

Check no error on phone, check the air trace and debug trace on device application.

Figure 11. Phone writes 4 bytes (test 6-2)

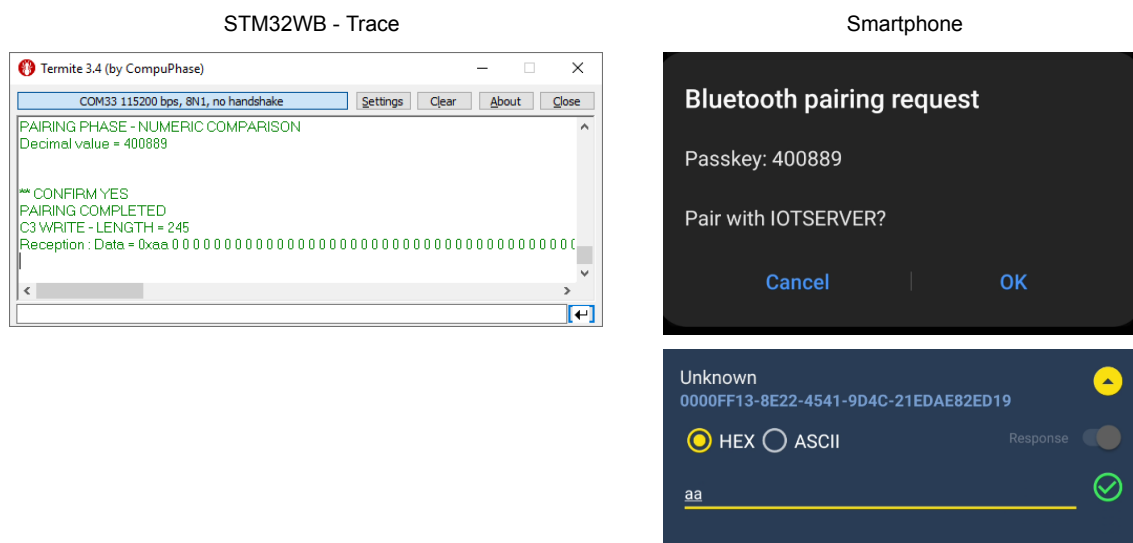


2.3.10 Test 7 – GATT, write/read characteristic encryption permission

The test purpose is to write/read a characteristic with encryption permission needed. With most phones a pop-up appears (see [Figure 12](#)) to start the pairing. With some phones, pairing has to be done out of the BLE toolbox application.

- Phone reads/writes a fixed length value – 245
- Pairing done (encrypted link)
- Pass if phone can read/write the characteristic
- Check response in the air trace, no error on phone
- Check debug trace on device application

Figure 12. Phone writes one byte, encryption needed



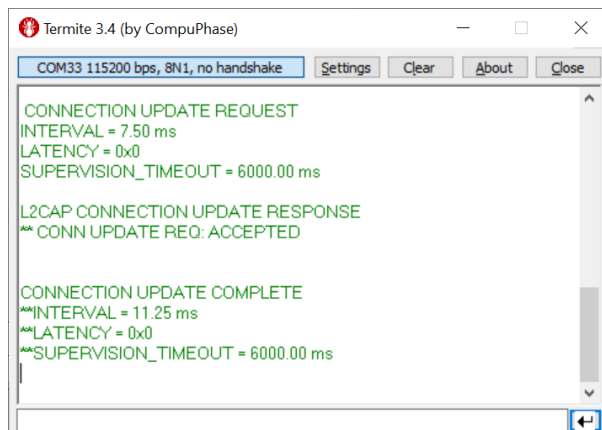
2.3.11 Test 8-1 – L2CAP connection interval request (7.5 ms)

STM32WB55 device is the peripheral.

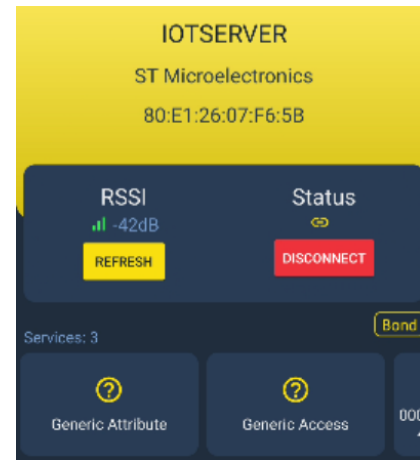
- Phone scans, connects, discovers service/characteristic
- Peripheral requests a new connection interval (7.5 ms, 20 ms, 45 ms, 200 ms, 400 ms, 1 s, 2 s, 4 s)
- Push SW1 – new connection interval requested: 7.5 ms
- Accepted, phone requests 11.5 ms

Figure 13. Peripheral requests connection interval, 7.5 ms

STM32WB - Trace



Smartphone

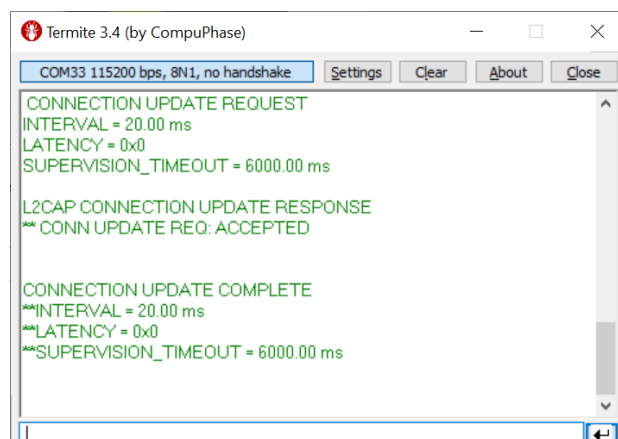


2.3.12 Test 8-2 – L2CAP connection interval request (20 ms)

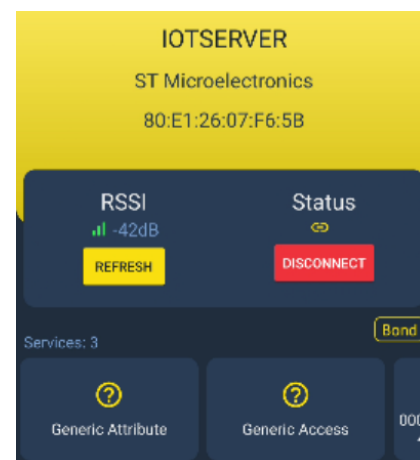
- Push SW1 – new connection interval requested: 20 ms
- Accepted, phone requests 20 ms

Figure 14. Peripheral requests connection interval, 20 ms

STM32WB - Trace



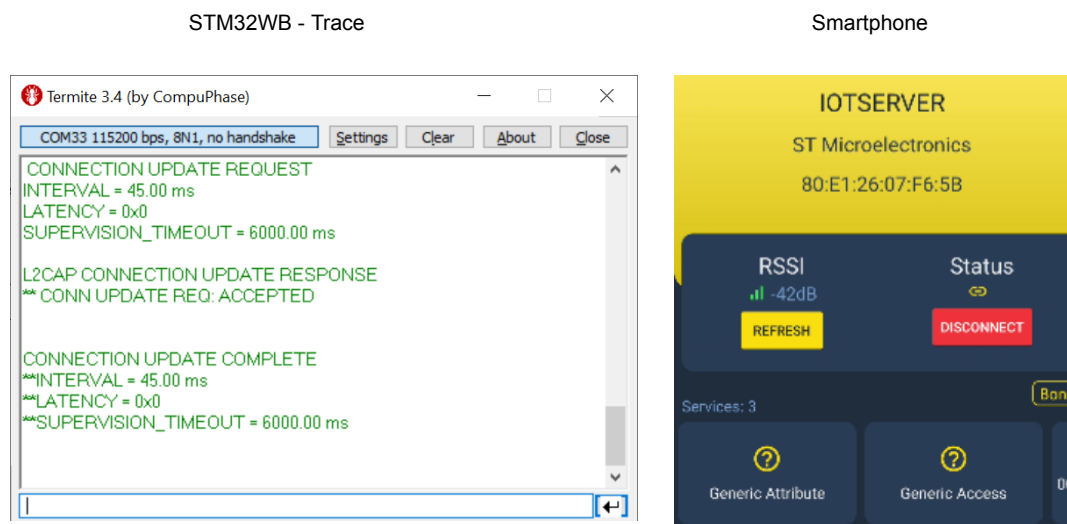
Smartphone



2.3.13 Test 8-3 – L2CAP connection interval request (45 ms)

- Push SW1 – new connection interval requested: 45 ms
- Accepted, phone requests 45 ms

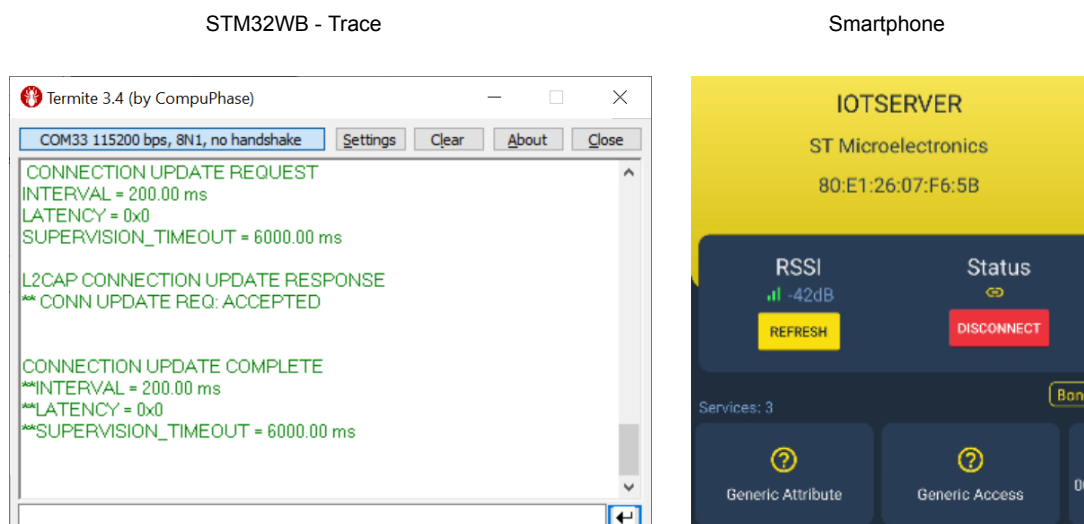
Figure 15. Peripheral requests connection interval, 45 ms



2.3.14 Test 8-4 – L2CAP connection interval request (200 ms)

- Push SW1 – new connection interval requested: 200 ms
- Accepted, phone requests 200 ms

Figure 16. Peripheral requests connection interval, 200 ms

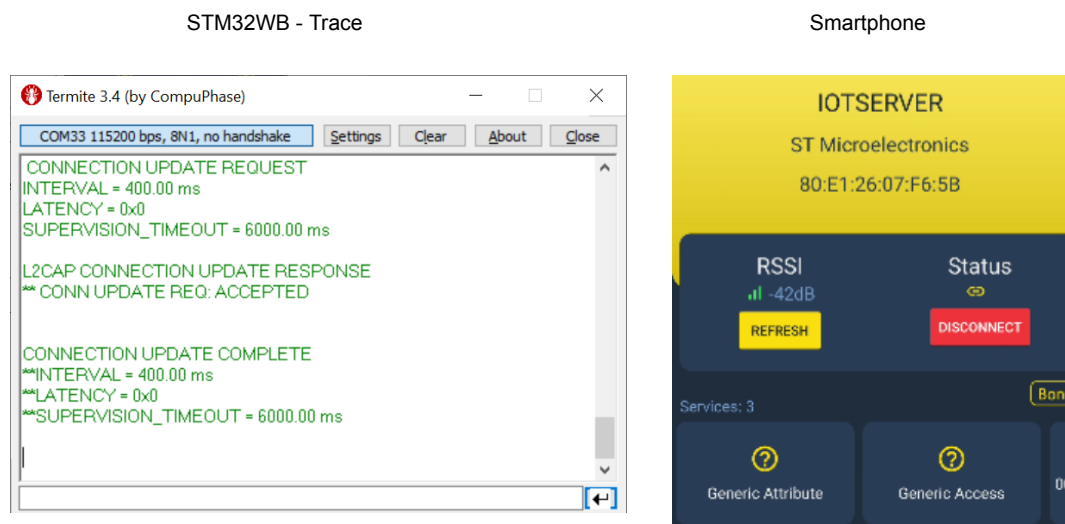


2.3.15

Test 8-5 – L2CAP connection interval request (400 ms)

- Push SW1 – new connection interval requested: 400 ms
- Accepted, phone requests 400 ms

Figure 17. Peripheral requests connection interval, 400 ms

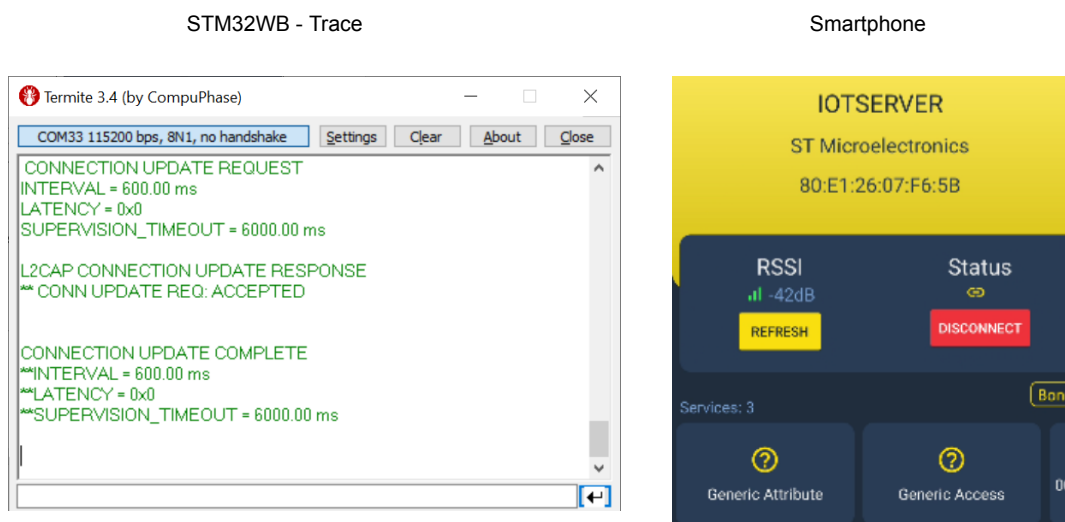


2.3.16

Test 8-6 – L2CAP connection interval request (600 ms)

- Push SW1 – new connection interval requested: 600 ms
- Accepted, phone requests 600 ms

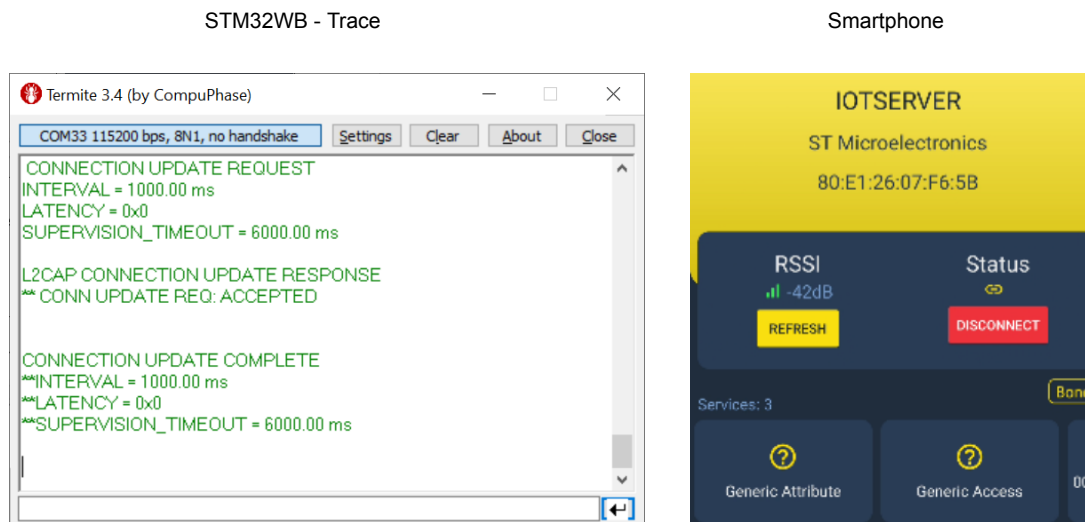
Figure 18. Peripheral requests connection interval, 600 ms



2.3.17 Test 8-7 – L2CAP connection interval request (1000 ms)

- Push SW1 – new connection interval requested: 1000 ms
- Accepted, phone requests 1000 ms

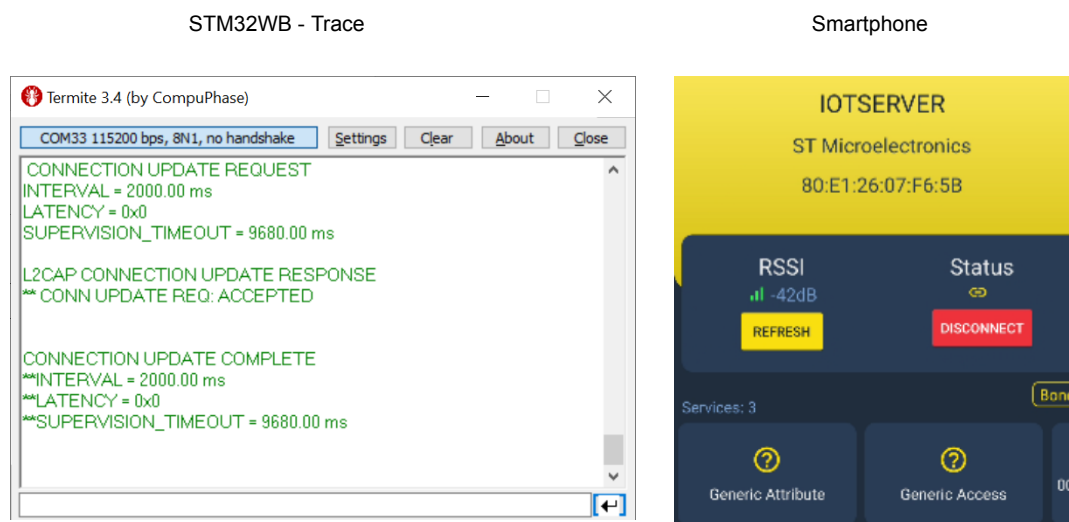
Figure 19. Peripheral requests connection interval, 1000 ms



2.3.18 Test 8-8 – L2CAP connection interval request (2000 ms)

- Push SW1 – new connection interval requested: 2000 ms
- Accepted, phone requests 2000 ms

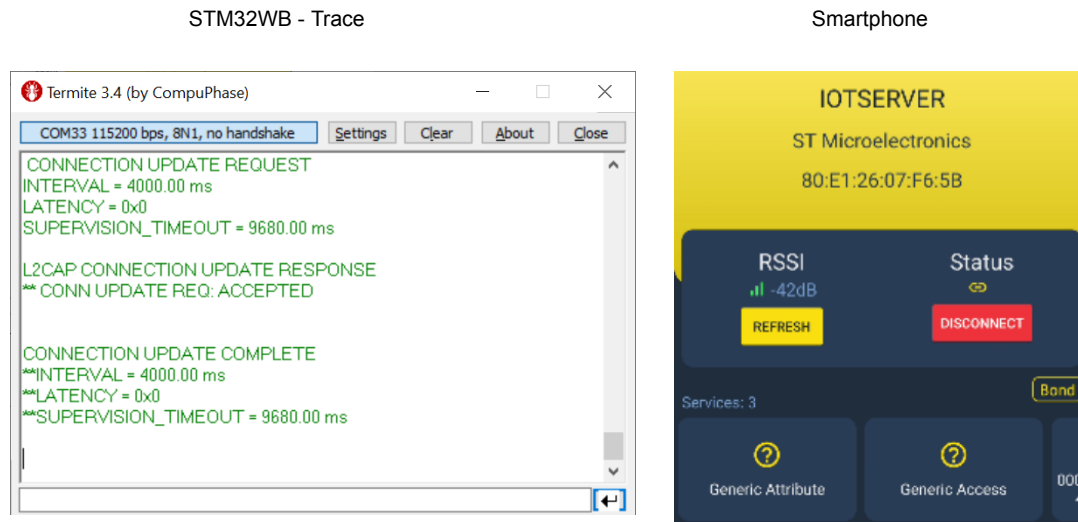
Figure 20. Peripheral requests connection interval, 2000 ms



2.3.19 Test 8-9 – L2CAP connection interval request (4000 ms)

- Push SW1 – new connection interval requested: 4000 ms
- Accepted, phone requests 4000 ms

Figure 21. Peripheral requests connection interval, 4000 ms

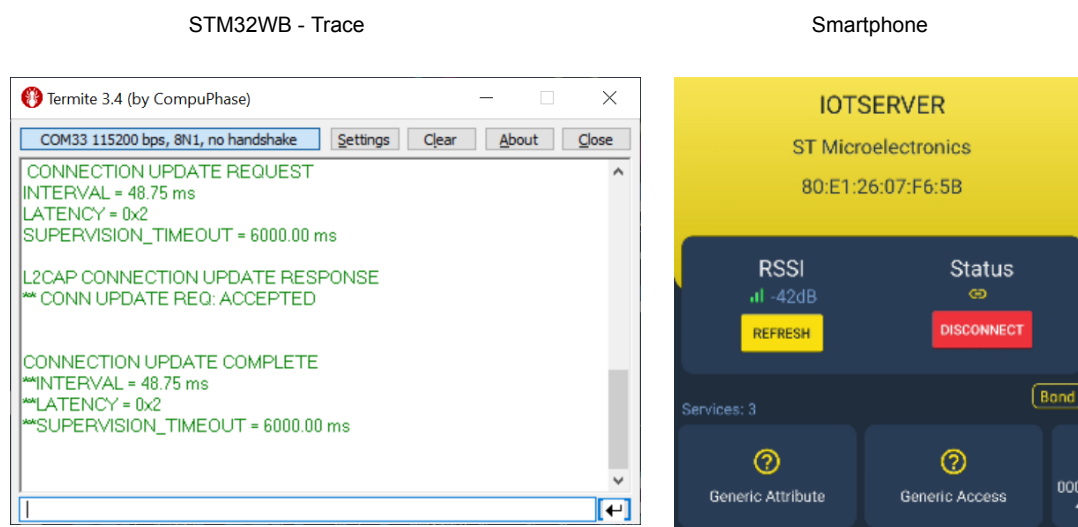


2.3.20 Test 9-1 – L2CAP connection interval, connection latency request (48.75 ms, latency = 2)

STM32WB55 device is the peripheral.

- Phone scans, connects, discovers service/characteristic
- Peripheral requests a new connection interval and new connection latency (48.75 ms, L = 2; 48.75 ms, L = 4; 200 ms, L = 2; 200 ms, L = 4; 1s, L = 1)
- Push SW2 – new connection interval requested: 48.75 ms, latency = 2
- Accepted, phone requests 48.75 ms, latency = 2

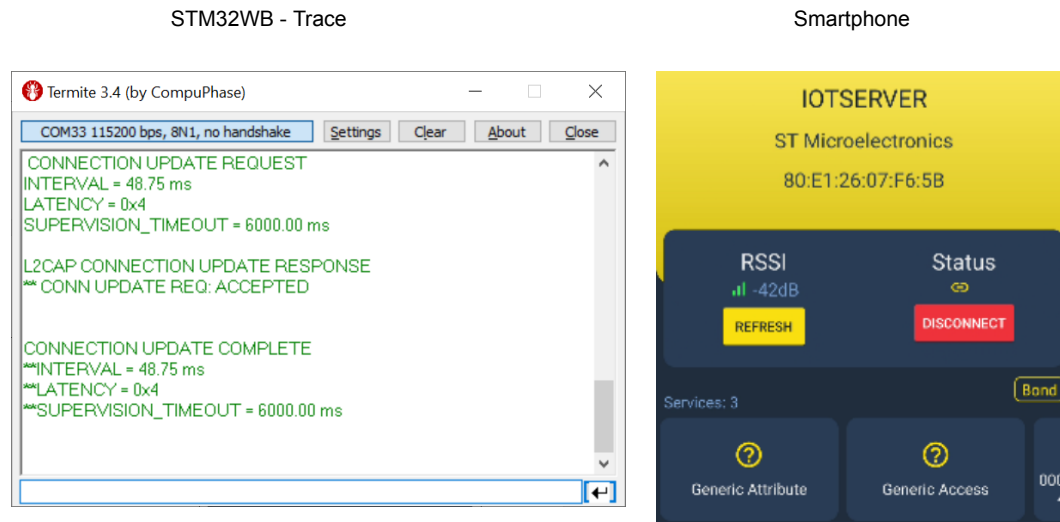
Figure 22. Peripheral requests connection interval = 48.75 ms, latency = 2



2.3.21 Test 9-2 – L2CAP connection interval, connection latency request (48.75 ms, latency = 4)

- Push SW2 – new connection interval requested: 48.75 ms, latency = 4
- Accepted, phone requests 48.75 ms, latency = 4

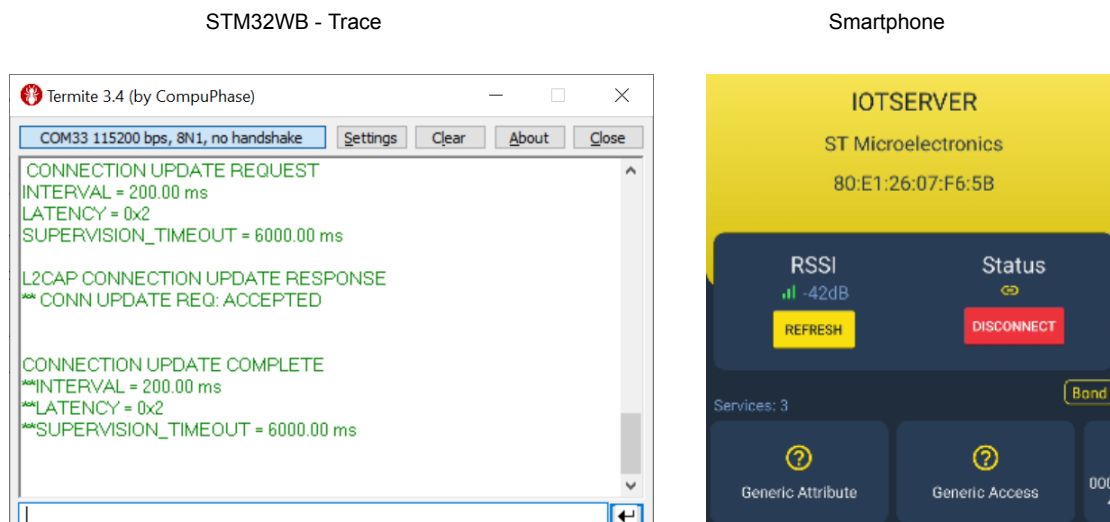
Figure 23. Peripheral requests connection interval = 48.75 ms, latency = 4



2.3.22 Test 9-3 – L2CAP connection interval, connection latency request (200 ms, latency = 2)

- Push SW2 – new connection interval requested: 200 ms, latency = 2
- Accepted, phone requests 200 ms, latency = 2

Figure 24. Peripheral requests connection interval = 200 ms, latency = 2

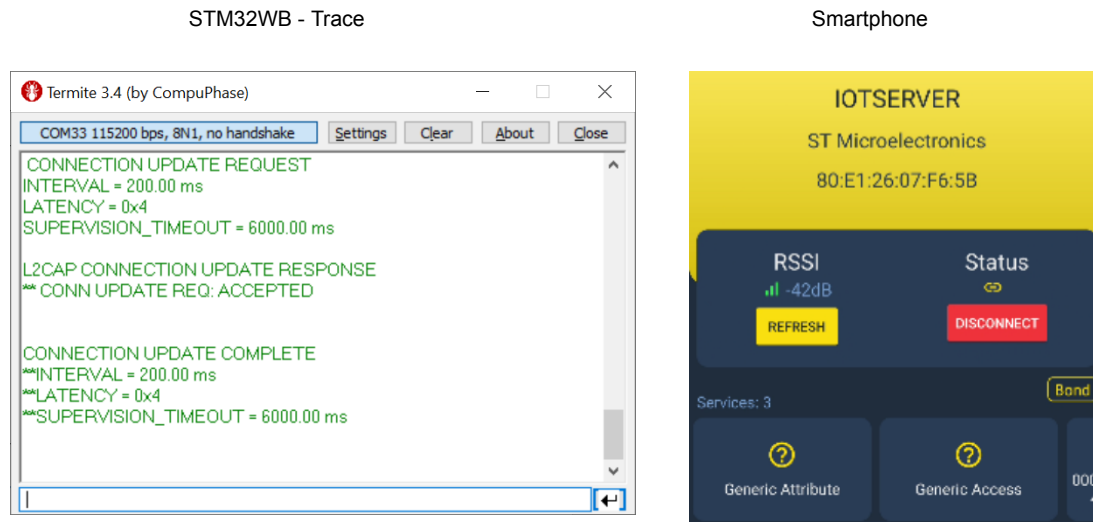


2.3.23

Test 9-4 – L2CAP connection interval, latency request (200 ms, latency = 4)

- Push SW2 – new connection interval requested: 200 ms, latency = 4
- Accepted, phone requests 200 ms, latency = 4

Figure 25. Peripheral requests connection interval = 200 ms, latency = 4

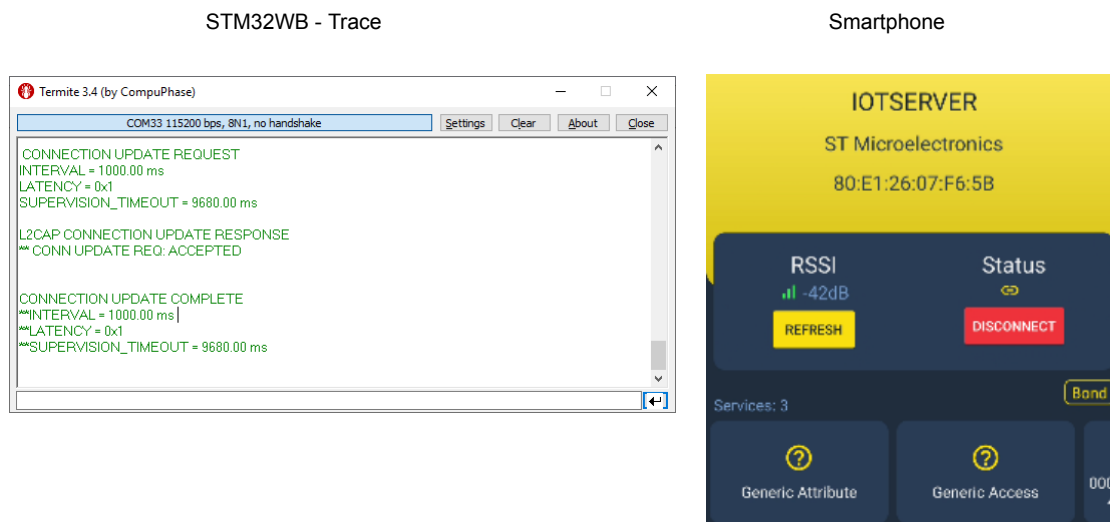


2.3.24

Test 9-5 – L2CAP connection interval, latency request (1000 ms, latency = 1)

- Push SW2 – new connection interval requested: 1000 ms, latency = 1
- Accepted, phone requests 1000 ms, latency = 1

Figure 26. Peripheral requests connection interval equals to 1000 ms, latency equals to 1



2.4 Results of basic functional tests

Table 3. Results of basic functional tests

Manufacturer	Model	OS	1	2	3	4	5	6	7	8	9
Apple®	iPhone 7 MN8X2ZD/A	iOS 13.7	✓	✓	✓	✓	✓	✓	✓	✓ (1)	✓ (2)
Apple®	iPhone 8 MQ6V2LL/A	iOS 14.0.1	✓	✓	✓	✓	✓	✓	✓	✓ (1)	✓ (2)
Apple®	iPhone11	iOS 13.6.1	✓	✓	✓	✓	✓	✓	✓	✓ (1)	✓ (2)
Apple®	iPhone12	iOS 14.3	✓	✓	✓	✓	✓	✓	✓	✓ (1)	✓ (2)
Apple®	XR MRYU2VC/A	iOS 14	✓	✓	✓	✓	✓	✓	✓	✓ (1)	✓ (2)
Apple®	XS MT9H2ZD/A	iOS 13.6.1	✓	✓	✓	✓	✓	✓	✓	✓ (1)	✓ (2)
Apple®	XS MAX	iOS 14.2	✓	✓	✓	✓	✓	✓	✓	✓ (1)	✓ (2)
Google®	PIXEL2	R v11 API level 30	✓	✓	✓	✓	✓	✓	✓	✓ (3)	✓
Google®	PIXEL3	Q v10 API level 29	✓	✓	✓	✓	✓	✓	✓	✓ (3)	✓
Huawei	Mate 20 LITE	Q v10 API level 29	✓	✓	✓	✓	✓	✓	✓	✓ (3)	✓
Huawei	NEXUS 6P	Oreo v8.1.0 API level 27	✓	✓	✓	✓	✓	✓	✓	✓ (3)	✓
Huawei	P10	Nougat v7.0 API level 24	✓	✓	✓	✓	✓	✓	✓	✓	✓
Huawei	P20 ELM-L29	Oreo v8.1.0 API level 27	✓	✓	✓	✓	✓	✓	✓	✓	✓
Huawei	P30 ELE-L29	Q v10 API level 29	✓	✓	✓	✓	✓	✓	✓	✓ (3)	✓
Huawei	P Smart+ 2019 POT-LX1T	Q v10 API level 29	✓	✓	✓	✓	✓	✓	✓	✓ (3)	✓
LG	K20	Pie v9 API level 28	✓	✓	✓	✓	✓	✓	✓	✓ (3)	✓
Motorola	Z2	Nougat v7.1.1 API level 25	✓	✓	✓	✓	✓	✓	✓	✓ (3)	✓
OnePlus	5000	Nougat v7.1.1 API level 25	✓	✓	✓	✓	✓	✓	✓	✓ (4)	✓
OnePlus	A6003	Q v10 API level 29	✓	✓	✓	✓	✓	✓	✓	(4)	✓
OPPO	RX17 PRO CPH1877	Oreo v8.0 API level 26	✓	✓	✓	✓	✓	✓	✓	✓ (3)	✓
Samsung	A41	Q v10	✓	✓	✓	✓	✓	✓	✓	✓ (3)	✓

Manufacturer	Model	OS	1	2	3	4	5	6	7	8	9
	SM-A415F	API level 29									
Samsung	A50 SM-A505FN	Q v10 API level 29	✓	✓	✓	✓	✓	✓	✓	✓ ⁽³⁾	✓
Samsung	A51	Q v10 API level 29	✓	✓	✓	✓	✓	✓	✓	✓ ⁽³⁾	✓
Samsung	GALAXY A5	Oreo v8 API level 25	✓	✓	✓	✓	✓	✓	✓	✓ ⁽³⁾	✓
Samsung	GALAXY S7 SM-G930F	Oreo v8 API level 25	✓	✓	✓	✓	✓	✓	✓	✓ ⁽³⁾	✓
Samsung	GALAXY S8 SM-G950F	Nougat v7 API level 24	✓	✓	✓	✓	✓	✓	✓	✓ ⁽³⁾	✓
Samsung	GALAXY S8 SM-G9500	Nougat V7 API level 24	✓	✓	✓	✓	✓	✓	✓	✓ ⁽⁴⁾	✓
Samsung	GALAXY S8+ Chinese model SM-G9550	Nougat V7 API level 24	✓	✓	✓	✓	✓	✓	✓	✓ ⁽⁴⁾	✓
Samsung	GALAXY S9 SM-G900	Nougat v7.1.1 API level 25	✓	✓	✓	✓	✓	✓	✓	✓ ⁽³⁾	✓
Samsung	GALAXY S9 SM-G960	Nougat v7.1.1 API level 25	✓	✓	✓	✓	✓	✓	✓	✓ ⁽³⁾	✓
Samsung	GALAXY S10 SM-G730	Pie v9 API level 28	✓	✓	✓	✓	✓	✓	✓	✓ ⁽³⁾	✓
Samsung	GALAXY S10 SM-G973F	Pie v9 API level 28	✓	✓	✓	✓	✓	✓	✓	✓ ⁽³⁾	✓
Samsung	Tab A SM-T510	Q v10 API level 31	✓	✓	✓	✓	✓	✓	✓	✓ ⁽³⁾	✓
Samsung	NOTE 8 SM-N950F	Pie v9 API level 27	✓	✓	✓	✓	✓	✓	✓	✓ ⁽³⁾	✓
Samsung	S6 Edge SM-G925F	Nougat v7 API level 24	✓	✓	✓	✓	✓	✓	✓	✓ ⁽³⁾	✓
Samsung	S10 SM-G973F	Q v10 API level 30	✓	✓	✓	✓	✓	✓	✓	✓ ⁽³⁾	✓
Sony	XPERIA10	Pie v9 API level 28	✓	✓	✓	✓	✓	✓	✓	✓ ⁽³⁾	✓
Sony	XPERIA DOCOMO	Nougat v7.1.1 API level 28	✓	✓	✓	✓	✓	✓	✓	✓ ⁽³⁾	✓
Sony	XPERIA XZ2	Pie v9 API level 28	✓	✓	✓	✓	✓	✓	✓	✓ ⁽³⁾	✓
Xiaomi	MI5	Marshmallow API level 27	✓	✓	✓	✓	✓	✓	✓	✓	✓
Xiaomi	MI8	Oreo v8.1.0 API level 27	✓	✓	✓	✓	✓	✓	✓	✓ ⁽³⁾	✓
Xiaomi	MI10	Q v10 API level 23	✓	✓	✓	✓	✓	✓	✓	✓ ⁽³⁾	✓

Manufacturer	Model	OS	1	2	3	4	5	6	7	8	9
Xiaomi	MI MIX3	Q v10 API level 29	✓	✓	✓	✓	✓	✓	✓	✓ ⁽³⁾	✓
Xiaomi	REDMI M2004J19AG	Q v10 API level 30	✓	✓	✓	✓	✓	✓	✓	✓ ⁽³⁾	✓
Xiaomi	REDMI NOTE 8 M1908C3JG	Q v10 API level 29	✓	✓	✓	✓	✓	✓	✓	✓ ⁽³⁾	✓
Xiaomi	REDMI NOTE 8 PRO	Q v10 API level 29	✓	✓	✓	✓	✓	✓	✓	✓ ⁽³⁾	✓

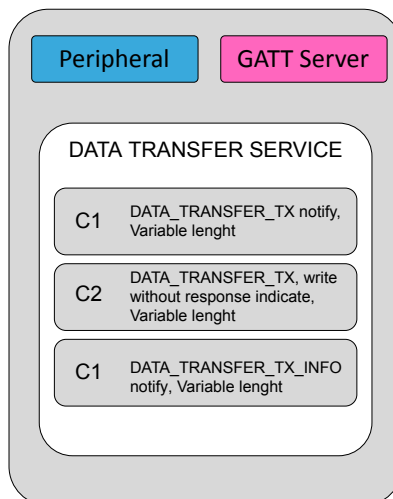
1. If requested connection interval < 30 ms, phone updates with a connection interval around 30 ms (26.25 ms or 30 ms). Other requests are accepted and answered with few differences.
2. L2CAP request with connection interval equals to 1 s and latency > 0 is not accepted.
3. If requested connection interval equals to 7.5 ms, phone updates with 11.25 ms.
4. If requested connection interval equals to 7.5 ms, phone's response is failed but test can continue.

3 Specific scenario test cases

3.1 STM32WB Series data throughput application

The application used for the following scenario is part of ST project delivery: BLE_Data_Throughput

Figure 27. BLE_Data_Throughput application



3.2 Summary of data throughput application tests

Table 4. List of data throughput application tests

Test set	Test case	Type
1	1	BLE connection, GATT (service, characteristic discovery)
2	1	GAP security – requested by the phone
	2	GAP security – requested by STM32WB55 device
3	1	Data throughput download (GATT notification) PHY 1 M
	2	Data throughput download (GATT notification) PHY 2 M
4	1	Data throughput upload (GATT write) PHY 1 M
	2	Data throughput upload (GATT write) PHY 2 M

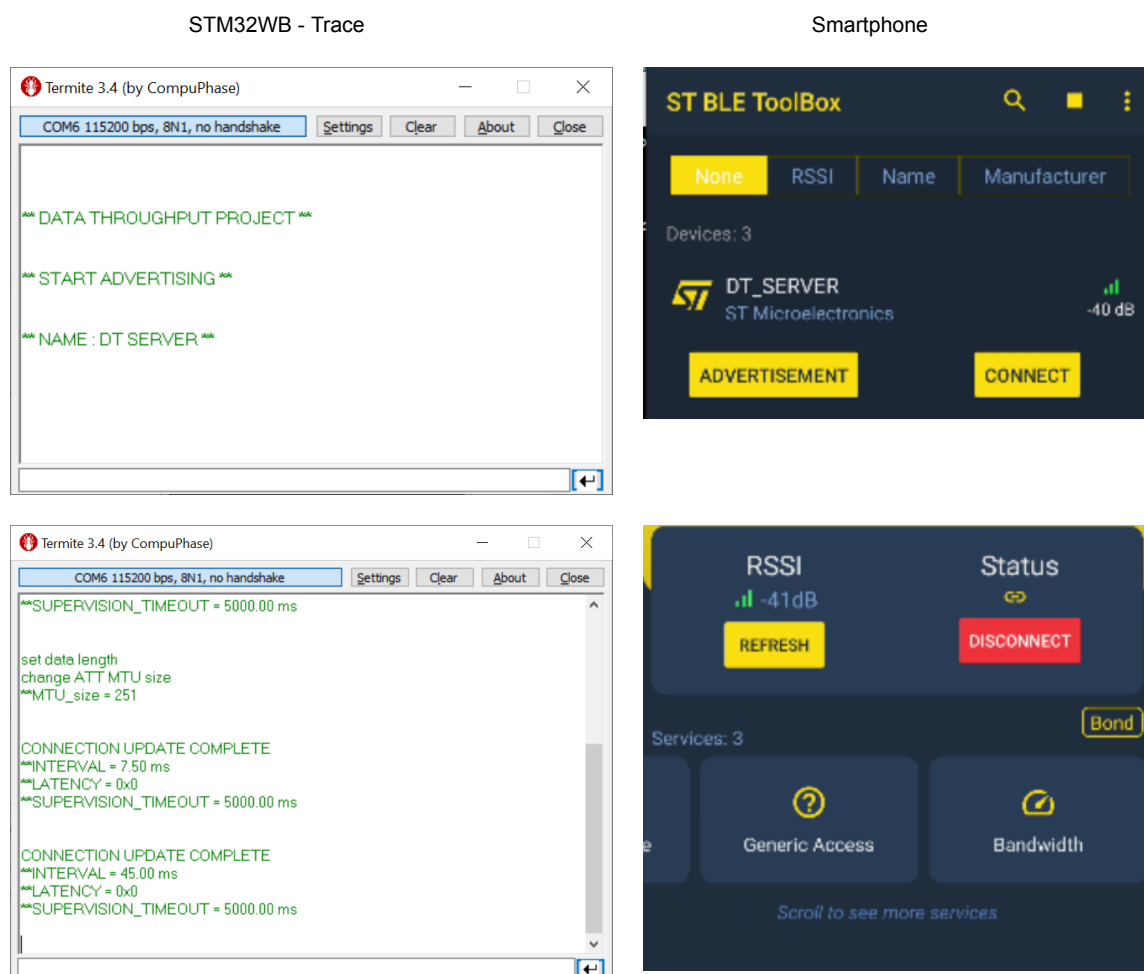
3.3 Description of data throughput application tests

3.3.1 Scenario 1 – BLE scanning, connection, service/characteristic discovery

STM32WB55 device is the peripheral.

- Phone connects, discovers service/characteristic, disconnects
- Pass if no connection issue and all service/characteristics are discovered by the phone

Figure 28. Phone scans, connects, discovers service and characteristics



3.3.2

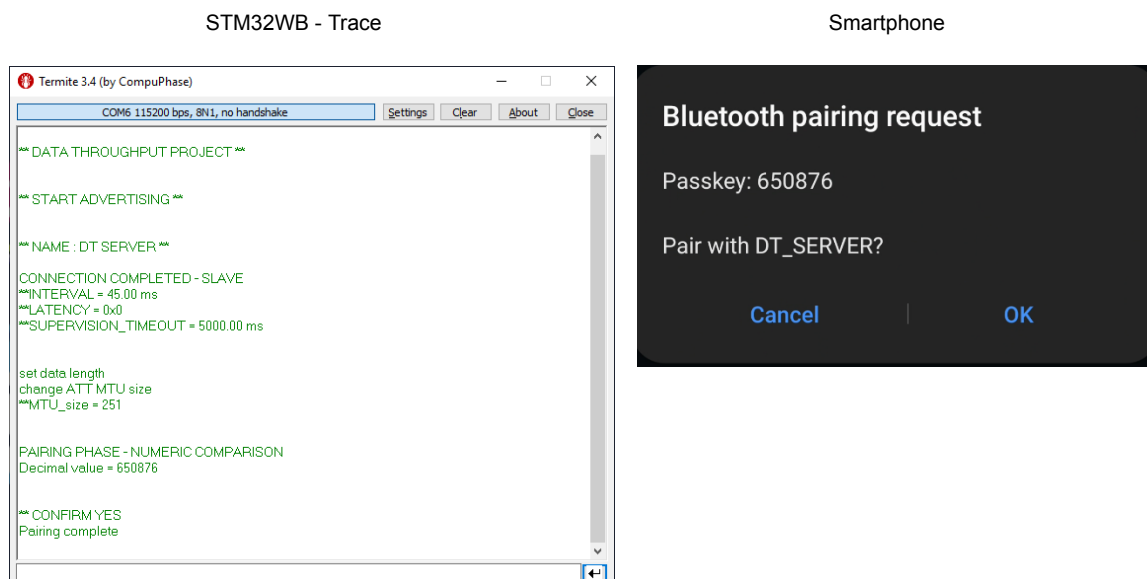
Scenario 2-1 – GAP security – Pairing requested by the phone

STM32WB55 device is in advertising.

STM32WB55 device can support legacy pairing or secure connection. The used method depends on the phone.

- Phone scans, connects, discovers service/characteristic
- The phone starts the pairing/bonding sequence
- Pass if after connection, pairing initiated by the phone is successful

Figure 29. Phone requests pairing



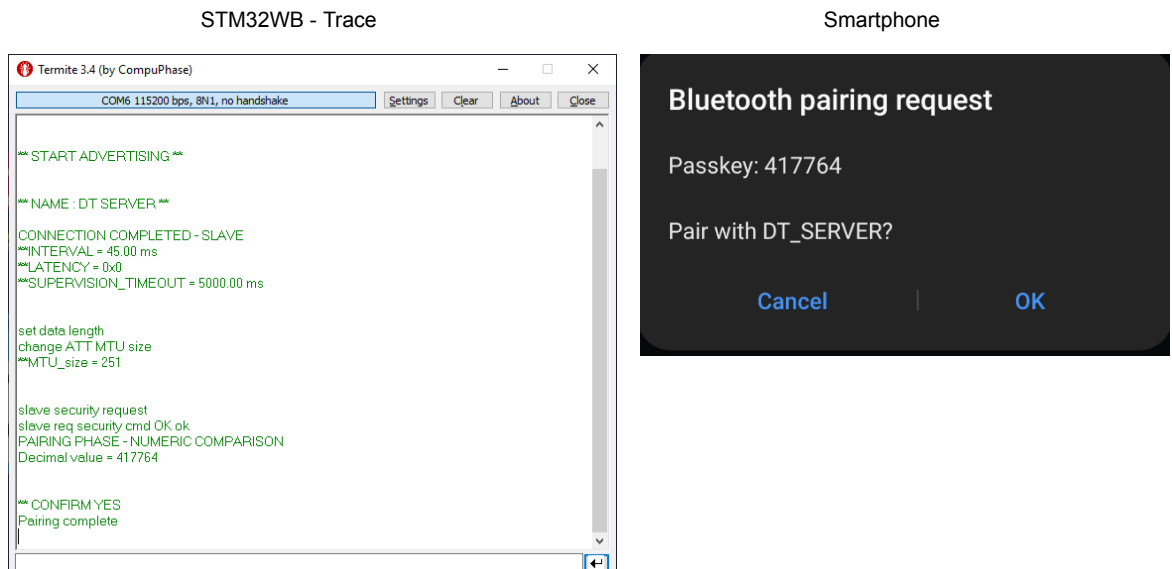
3.3.3 Scenario 2-2 – GAP security – Pairing requested by the STM32WB55 device

STM32WB55 device is in advertising.

STM32WB55 device can support legacy pairing or secure connection. The used method depends on the phone.

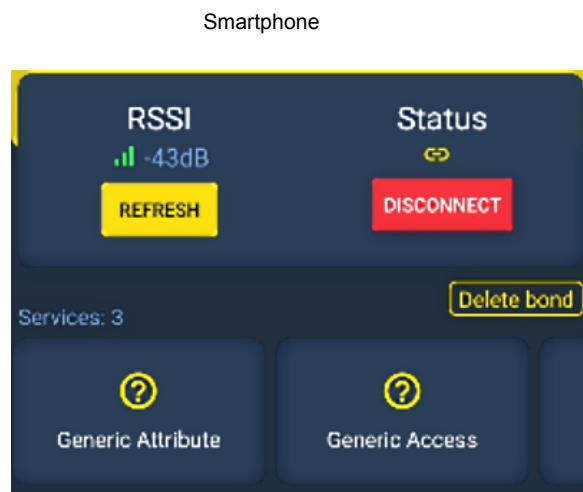
- Phone scans, connects, discovers service/characteristic
- The STM32WB55 device starts the pairing/bonding sequence
- Pass if after connection, pairing initiated by the phone is successful

Figure 30. STM32WB55 device requests pairing



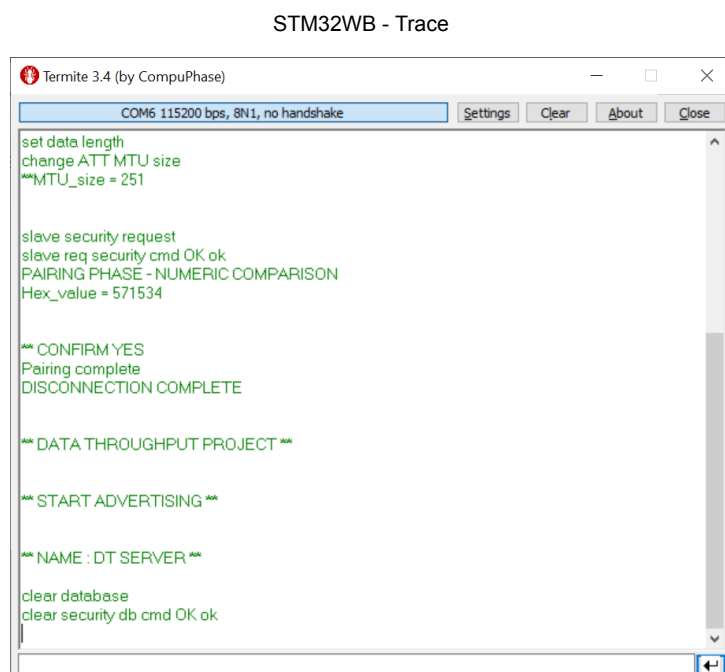
Note: The database can be deleted on phone using “delete bond”. Delete database is a local action.

Figure 31. Phone deletes its database



Note: The database can be deleted on STM32WB55 device after disconnection, using SW3-long push (more than 1 s). Delete database is a local action.

Figure 32. STM32WB55 device deletes its database



3.3.4 Scenario 3-1 – Data throughput downlink 1 M

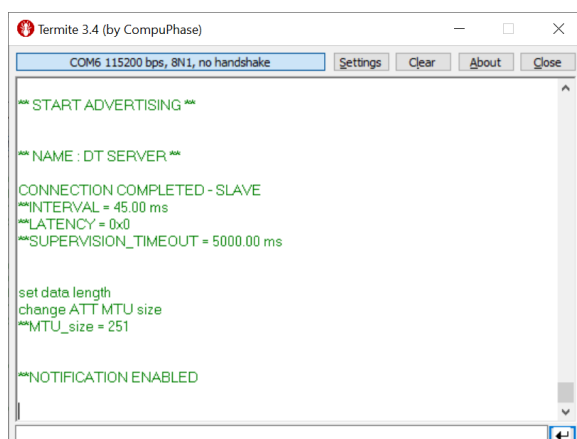
STM32WB55 device is the peripheral.

- Phone scans, connects, discovers service/characteristic, enables the notification
- Push SW1 – notification is sent from STM32WB55 device
- Throughput is calculated on the phone

Pass if all service and characteristics are discovered and the throughput value is displayed

Figure 33. STM32WB55 device sends data to the phone at PHY = 1 M

STM32WB - Trace



Smartphone



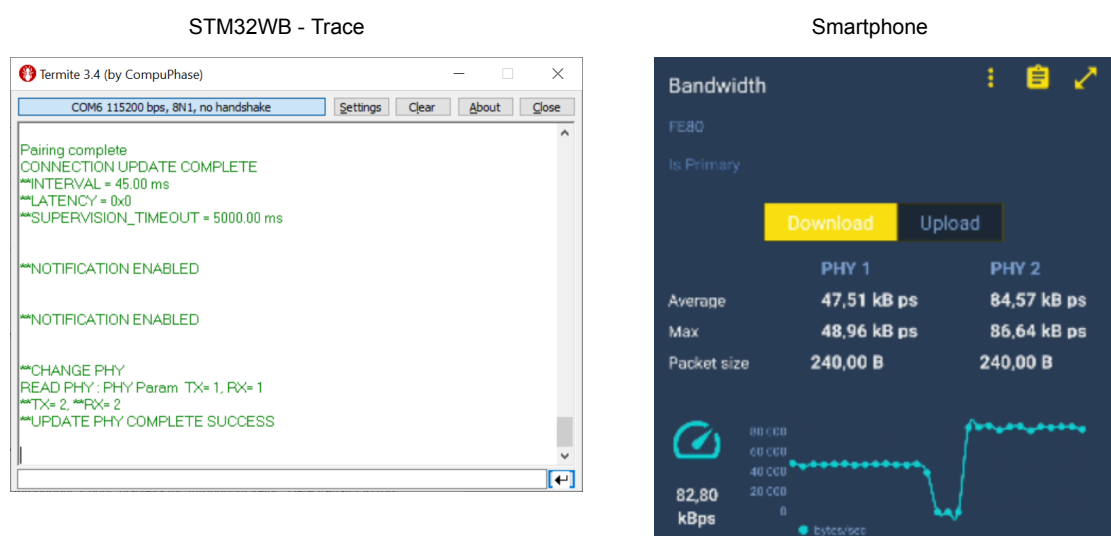
3.3.5 Scenario 3-2 – Data throughput downlink 2 M

STM32WB55 device is the peripheral.

- Phone scans, connects, discovers service/characteristic, enables the notification
- Push SW1 : notification are sent from STM32WB55 device
- Push SW2, check the phone supports PHY 2 M
- Throughput is calculated on the phone

Pass if all service and characteristics are discovered and the throughput value is displayed.

Figure 34. STM32WB55 device sends data to the phone at PHY = 2 M



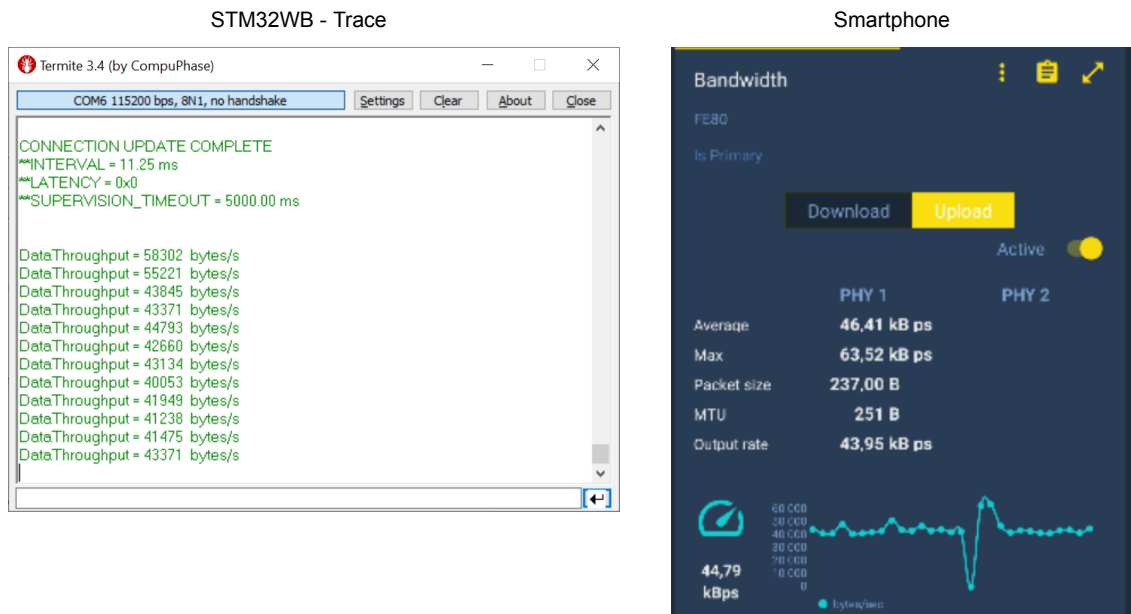
3.3.6 Scenario 4-1 – Data throughput uplink 1 M

STM32WB55 device is in advertising.

- Phone scans, connects, discovers service/characteristic, enables the notification (not used in this case)
- Select uplink box on phone application. Write data started from the phone
- Throughput is calculated on device and sent to the phone through a notification. The value is displayed on phone

Pass if all service and characteristics are discovered and the throughput value is displayed.

Figure 35. Phone sends data to STM32WB55 device at PHY = 1 M



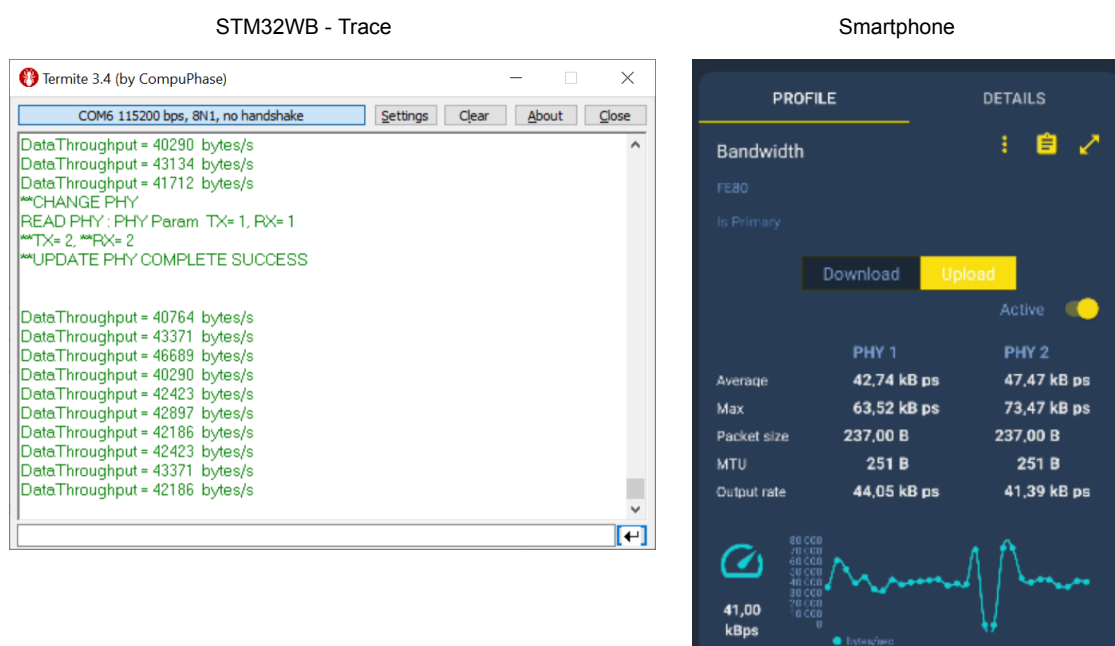
3.3.7 Scenario 4-2 – Data throughput uplink 2 M

STM32WB55 device is in advertising.

- Phone scans, connects, discovers service/characteristic, enables the notification (not used in this case)
- Select uplink box on phone application. Write data started from the phone
- Push SW2, check the phone supports PHY 2 M
- Throughput is calculated on device and sent to the phone through a notification. The value is displayed on phone.

Pass if all service and characteristics are discovered and the throughput value is displayed.

Figure 36. Phone sends data to STM32WB55 device at PHY = 2 M



3.4 Results of data throughput application tests

Table 5. Results of data throughput application tests

Manufacturer	Model	OS	S1	S2	S3-download (kbytes/s)	S4-upload (kbytes/s)
Apple®	iPhone 7 MN8X2ZD/A	iOS 13.7	✓	✓ SC	1 M - 22.11 2 M - 28.31	1 M - 21.8 2 M - 30.87
Apple®	iPhone 8 MQ6V2LL/A	iOS 14.0.1	✓	✓ SC	1 M - 24 2 M - 38	1 M - 23 2 M - 39
Apple®	iPhone 11	iOS 13.6.1	✓	✓ SC	1 M - 15 2 M - 40	1 M - 15 2 M - 39
Apple®	iPhone 12	iOS 14.3	✓	✓ SC	1 M - 23.2 2 M - 40	1 M - 23.4 2 M - 39
Apple®	XR MRYU2VC/A	iOS 14	✓	✓ SC	1 M - 24 2 M - 40	1 M - 23 2 M - 38
Apple®	XS MT9H2ZD/A	iOS 13.6.1	✓	✓ SC	1 M - 24 2 M - 40	1 M - 23 2 M - 40
Apple®	XS MAX	iOS 14.2	✓	✓ SC	1 M - 24 2 M - 38	1 M - 23 2 M - 39
Google®	PIXEL 2	R v11 API level 30	✓	✓ SC	1 M - 48.73 2 M - 85.90	1 M - 49.30 2 M - 85.20
Google®	PIXEL 3	Q v10 API level 29	✓	✓ SC	1 M - 48.7 2 M - 75	1 M - 42 2 M - 75
Huawei	MATE 20 LITE	Q v10 API level 29	✓	✓ SC	1 M - 22.3 2 M - not supported	1 M - 8 2 M - not supported
Huawei	NEXUS 6P	Oreo v8.1.0 API level 27	✓	✓ SC	1 M - 20 2 M - not supported	1 M - 42 2 M - not supported
Huawei	P10	Nougat v7 API level 24	✓	✓ SC	1 M - 30 2 M - 32	1 M - 30 2 M - 31
Huawei	P20 ELM-L29	Oreo v8.1.0 API level 27	✓	✓ SC ⁽²⁾	1 M - 19 2 M - 32	1 M - 31 2 M - 31
Huawei	P30 ELE-L29	Q v10 API level 29	✓	✓ SC	1 M - 60 2 M - 105	1 M - 47 2 M - 78
Huawei	P Smart+ 2019 POT-LX1T	Q v10 API level 29	✓	✓ SC	1 M - 16 2 M - not supported	1 M - 2.6 2 M - not supported
LG	K20	Pie v9 API level 28	✓	✓ SC	1 M - 2 2 M - not supported	1 M - 0.87 2 M - not supported
Motorola	Z2	Nougat v7.1.1 API level 25	✓	✓ SC	1 M - 7.2 2 M - not supported	1 M - 7.2 2 M - not supported
OnePlus	5000	Nougat v7.1.1 API level 25	✓	✓ SC ⁽²⁾	1 M - 48 2 M - 90	1 M - 48 2 M - 46
OnePlus	A6003	Q v10 API level 29	✓	✓ SC ⁽²⁾	1 M - 62.2 2 M - 85.2	1 M - 62.7 2 M - 84

Manufacturer	Model	OS	S1	S2	S3-download (kbytes/s)	S4-upload (kbytes/s)
OPPO	RX17 PRO CPH1877	Oreo v8.1.0 API level 27	✓	✓ SC	1 M - 47 2 M - 84	1 M - 42 2 M - 61
Samsung	A41 SM-A415F	Q v10 API level 30	✓	✓ SC	1 M - 43 2 M - 74	1 M - 70 2 M - 74
Samsung	A50 SM-A505FN	Q v10 API level 30	✓	✓ SC	1 M - 47 2 M - 85	1 M - 46 2 M - 46
Samsung	A51	Q v10 API level 29	✓	✓ SC	1 M - 43.10 2 M - 77.75	1 M - 46.10 2 M - 47.20
Samsung	GALAXY A5 SM-A520F	Oreo v8 API level 25	✓	✓ SC	1 M - 35 2 M - not supported	1 M - 28 2 M - not supported
Samsung	GALAXY S7 SM-G930F	Oreo v8 API level 25	✓	✓ SC	1 M - 24.02 2 M - not supported	1 M - 23.79 2 M - not supported
Samsung	GALAXY S8 SM-G950F	Nougat v7 API level 24	✓	✓ SC	1 M - 69 2 M - 74	1 M - 42 2 M - 46
Samsung	GALAXY S8 SM-G9500	Nougat V7 API level 24	✓	✓ SC	1 M - 93 2 M - 150	1 M - 48 2 M - 48
Samsung	GALAXY S8+ Chinese model SM-G9550	Nougat V7 API level 24	✓	✓ SC	1 M - 93 2 M - 164	1 M - 51 2 M - 50
Samsung	GALAXY S9 SM-G900	Nougat v7.1.1 API level 25	✓	✓ SC	1 M - 93 2 M - 166	1 M - 42 2 M - 76
Samsung	GALAXY S9 SM-G960	Nougat v7.1.1 API level 25	✓	✓ SC	1 M - 93 2 M - 167	1 M - 42 2 M - 57
Samsung	GALAXY S10 SM-G730	Pie v9 API level 28	✓	✓ SC	1 M - 93 2 M - 167	1 M - 42 2 M - 76
Samsung	GALAXY S10 SM-G973F	Pie v9 API level 28	✓	✓ SC	1 M - 93 2 M - 167	1 M - 43 2 M - 76
Samsung	Tab A SM-T510	Q v10 API level 29	✓	✓ SC ⁽²⁾	1 M - 37.6 2 M - 64.8	1 M - 48.2 2 M - 57.2
Samsung	NOTE 8 SM-N950F	Pie v9 API level 27	✓	✓ SC	1 M - 86.6 2 M - 156.25	1 M - 35.15 2 M - 37.1
Samsung	S6Edge	Nougat v7 API level 24	✓	✓ SC	1 M - 2.48 2 M - not supported	1 M - 2 2 M - not supported
Samsung	S10	Q v10 API level 30	✓	✓ SC	1 M - 91.7 2 M - 162.3	1 M - 46.18 2 M - 79
Sony	XPERIA10	Pie v9 API level 28	✓	✓ SC	1 M - 49.15 2 M - 86.11	1 M - 48.21 2 M - 75.29
Sony	XPERIA DOCOMO	Nougat v7.1.1 API level 25	✓	✓ SC	1 M - 42 2 M - 86	1 M - 38 2 M - 52
Sony	XPERIA XZ2	Pie v9 API level 28	✓	✓ SC	1 M - 49.3 2 M - 145.5	1 M - 8.7 2 M - 8.6
Xiaomi	MI5	Marshmallow	✓	✓ SC	1 M - 29.8 2 M - not supported	1 M - 31.5 2 M - not supported

Manufacturer	Model	OS	S1	S2	S3-download (kbytes/s)	S4-upload (kbytes/s)
		API level 27				
Xiaomi	MI 8	Oreo v8.1.0 API level 27	✓	✓ SC ⁽²⁾	1 M - 43 2 M - 85	1 M - 42 2 M - 74
Xiaomi	MI10 M2001J2G	Q v10 API level 29	✓	✓ SC	1 M - 72 2 M - 138	1 M - 55 2 M - 55
Xiaomi	MI MIX3	Q v10 API level 29	✓	✓ SC	1 M - 47.1 2 M - 82.5	1 M - 43 2 M - 80
Xiaomi	REDMI M2004J19AG	Q v10 API level 29	✓	✓ SC	1 M - 73 2 M - 75	1 M - 27 2 M - 39
Xiaomi	REDMI NOTE 8	Q v10 API level 29	✓	✓ SC	1 M - 45 2 M - not supported	1 M - 16 2 M - not supported
Xiaomi	REDMI NOTE 8 PRO	Q v10 API level 29	✓	✓ SC	1 M - 73.4 2 M - 127.7	1 M - 27.1 2 M - 40.6

1. SC stay for secure connection
2. Peripheral security request not supported by the phone.

4 Analysis

Figure 37. Data throughput download 1 M and 2 M performances

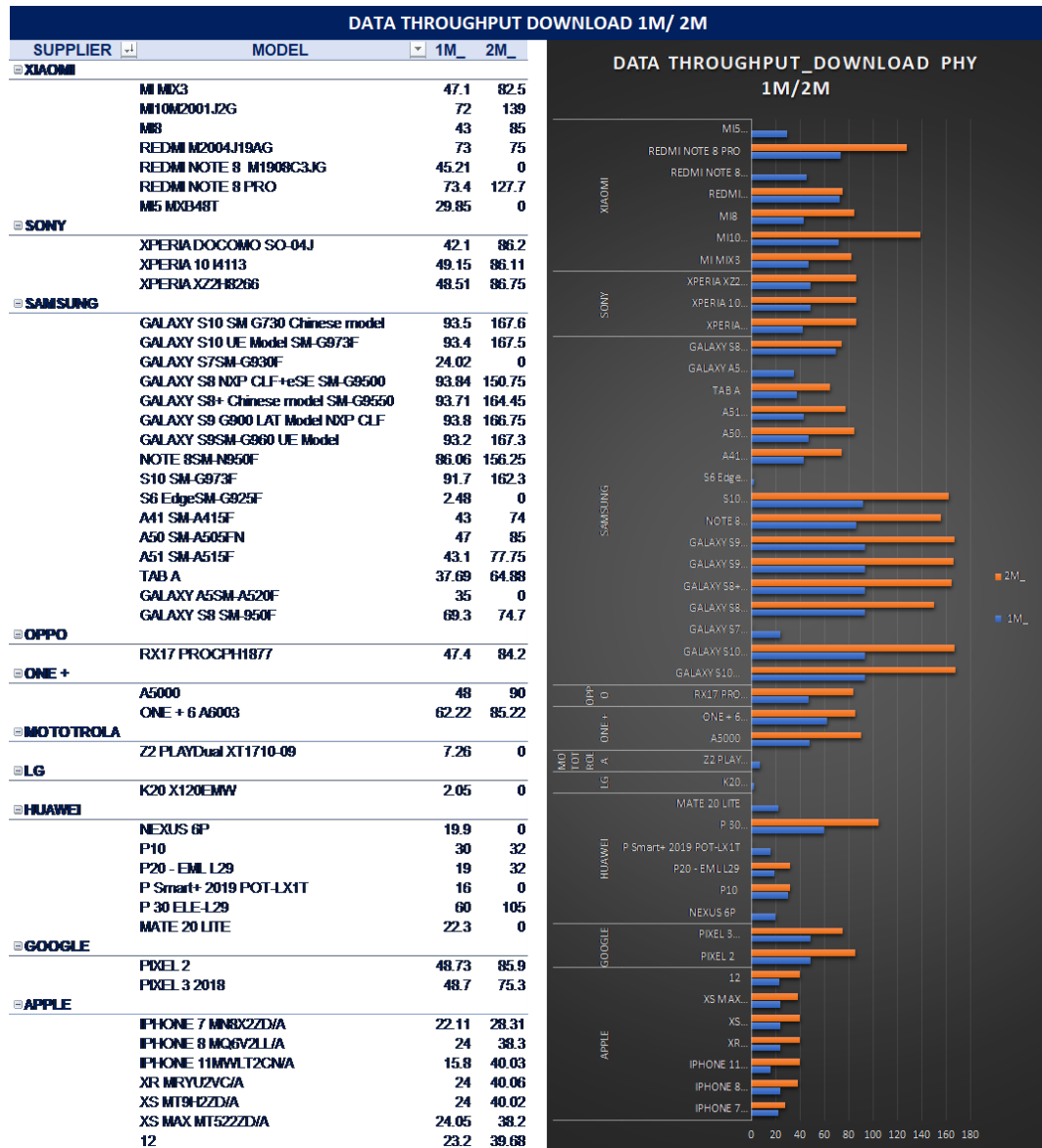


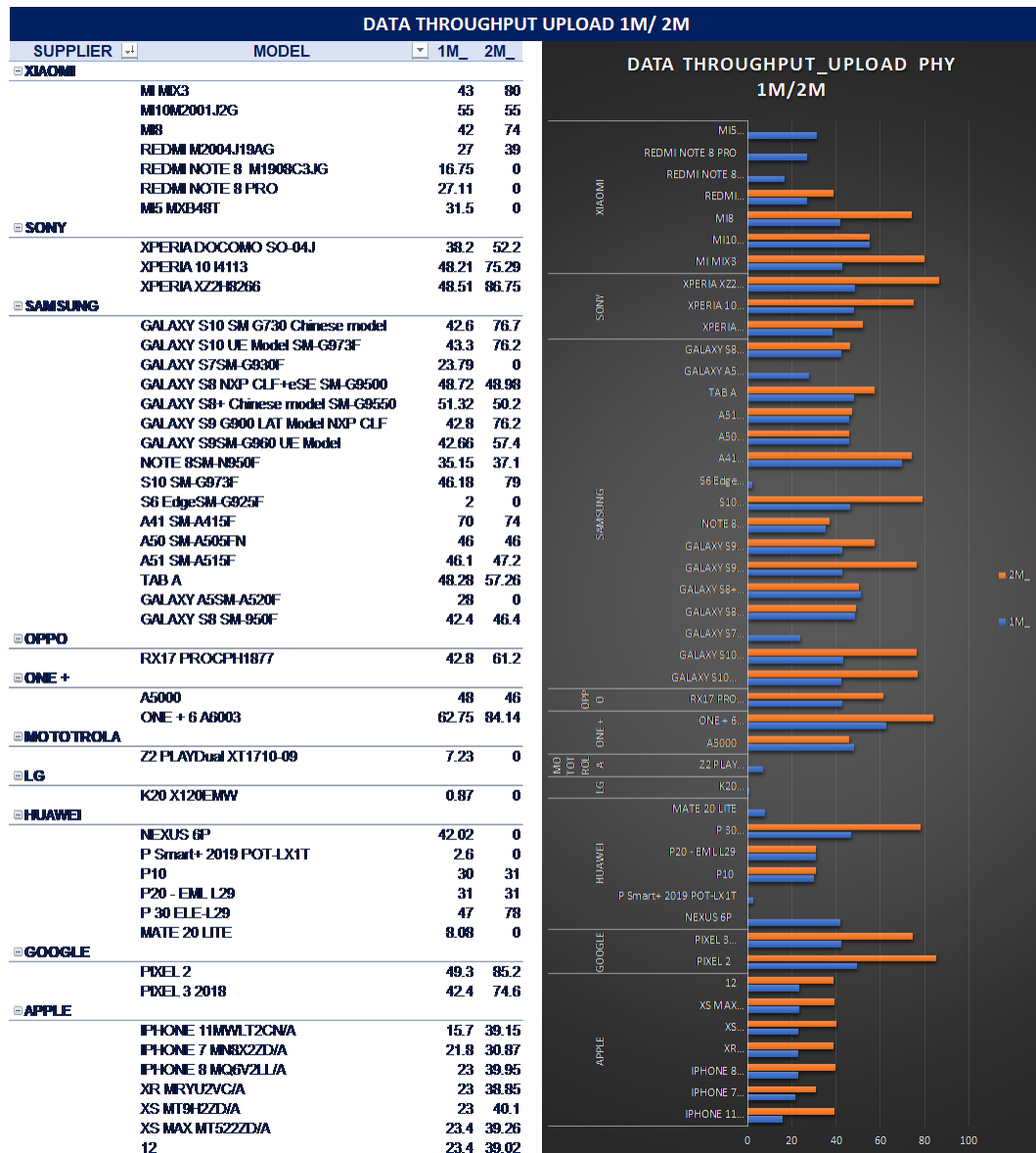
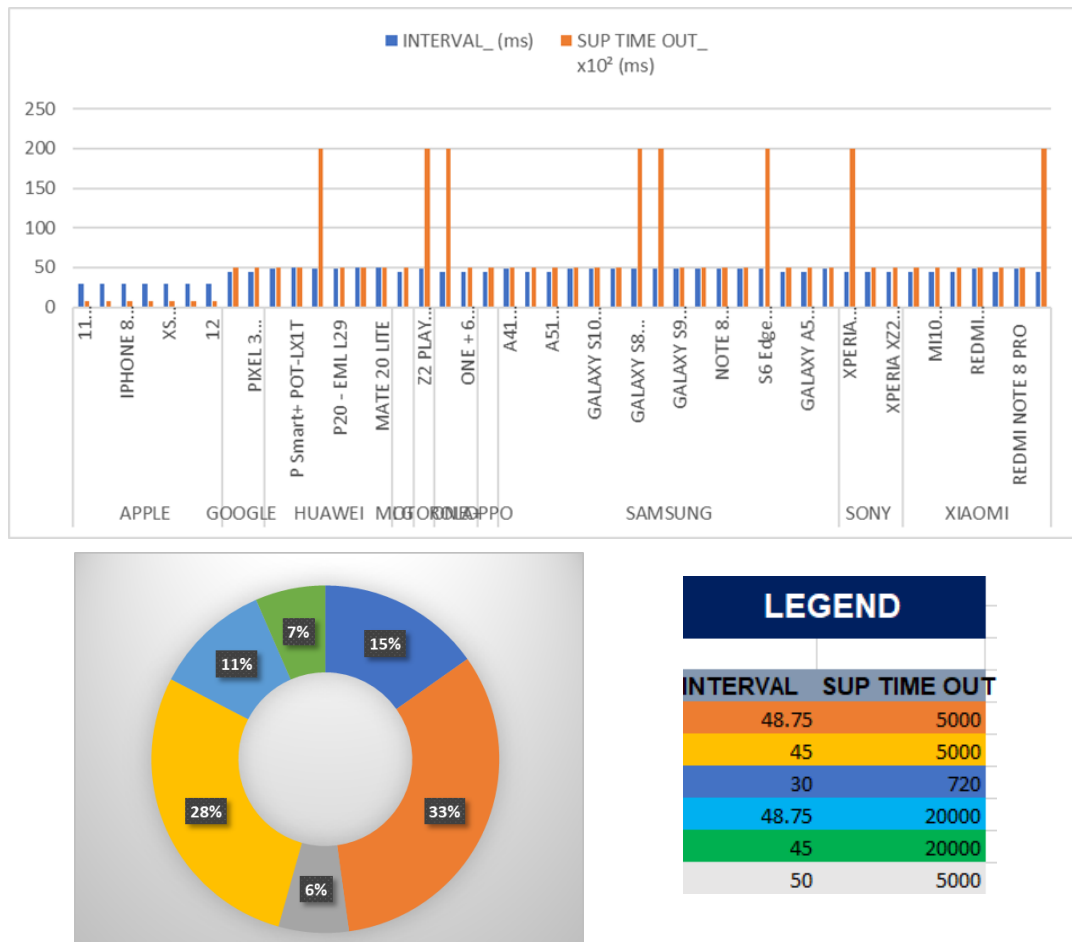
Figure 38. Data throughput upload 1 M and 2 M performances


Figure 39. Connection interval and supervision timeout summary



Revision history

Table 6. Document revision history

Date	Version	Changes
02-Feb-2021	1	Initial release.

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